

TRENCH Gen5 TMOS

DIM600M1HS17-PA500

Half Bridge IGBT Module

DS6329-3 September 2021 (LN41204)

Replaces DS6329-2

FEATURES

- Trench Gate IGBT
- **High Thermal Cycling**
- Cu Base with Enhanced Al₂O₃ Substrates
- 10µs Short Circuit Withstand

APPLICATIONS

- Wind Turbines
- Power Charging Equipment
- Smart Grid
- High Reliability Inverters

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM600M1HS17-PA500 is a half bridge 1700V, trench gate, insulated gate bipolar transistor (IGBT) module with enhanced field stop and implantation technology. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM600M1HS17-PA500

Note: When ordering, please use the complete part number

KEY PARAMETERS

V_{CES}		1700V
V _{CE(sat)}	* (typ)	1.80V
Ic	(max)	600A
I _{C(RM)}	(max)	1200A

^{*} Measured at the auxiliary terminals

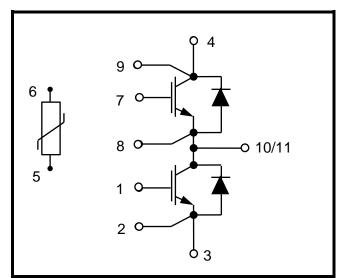


Fig. 1 Circuit configuration



Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions		Units
Vces	Collector-emitter voltage	V _{GE} = 0V, T _C = 25°C	1700	V
V _{GES}	Gate-emitter voltage	T _C = 25°C	±20	V
Ic	Continuous collector current	T _C = 100°C, T _{vj} max = 175°C	600	Α
I _{C(PK)}	Peak collector current	t _P = 1ms	1200	Α
P _{max}	Max. transistor power dissipation	Tc = 25°C, T _{vj} = 175°C	3.26	kW
l²t	Diode I ² t value	$V_R = 0$, $t_p = 10$ ms, $T_{vj} = 150$ °C	41.5	kA ² s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	3400	V

THERMAL AND MECHANICAL RATINGS

Internal insulation material: Al₂O₃

Baseplate material: Cu

Creepage distance – Terminal to heatsink:

Creepage distance – Terminal to terminal:

Clearance – Terminal to heatsink:

Clearance – Terminal to heatsink:

12.5mm

Clearance – Terminal to terminal:

10mm

CTI (Comparative Tracking Index):

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – IGBT	Continuous dissipation –			46	°C/kW
R _{th(j-c)}	Thermal resistance – diode	junction to case			80	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (IGBT)	Mounting torque 5Nm (with mounting grease 1W/m °C)		33		°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (Diode)			38		°C/kW
_	T _j Junction temperature IGBT Diode	IGBT	-40		150	°C
l j		Diode	-40		150	°C
T_{stg}	Storage temperature range	-	-40		125	°C
	Screw torque	Mounting – M5	3		6	Nm
		Electrical connections – M6	3		6	Nm

ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
		VGE = 0V, VCE = VCES			1	mA
Ices	Collector cut-off current	VGE = 0V, VCE = VCES, TC = 125°C			15	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _C = 150°C			30	mA
I _{GES}	Gate leakage current	V _{GE} = ± 20V, V _{CE} = 0V			0.5	μA
V _{GE(TH)}	Gate threshold voltage	Ic = 15mA, V _{GE} = V _{CE}	5.60	6.20	6.80	V
		V _{GE} = 15V, I _C = 600A		1.80	2.20	V
$V_{\text{CE(sat)}}$	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 600A, T _j = 125°C		2.20		V
		V _{GE} = 15V, I _C = 600A, T _j = 150°C		2.30		V
l _F	Diode forward current	DC		600		Α
I _{FM}	Diode maximum forward current	$t_p = 1 ms$		1200		Α
	Diode forward voltage	I _F = 600A		1.85	2.25	V
VF		I _F = 600A, T _j = 125°C		2.10		V
		I _F = 600A, T _j = 150°C		2.10		V
C _{ies}	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 100kHz		96		nF
Qg	Gate charge	±15V		6.1		μC
Cres	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 100kHz		0.7		nF
L _M	Module inductance			20		nΗ
R _{INT}	Internal transistor resistance			1		mΩ
SC _{Data}	Short circuit current, I _{SC}	$T_{j} = 150^{\circ}\text{C}, \ V_{CC} = 1000\text{V}$ $t_{p} \le 10\mu\text{s}, \ V_{GE} \le 15\text{V}$ $V_{CE \ (max)} = V_{CES} - L^{*} x \ dI/dt$ $IEC \ 60747-9$		2400		А

Note:

NTC-Thermistor Data

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
R ₂₅	Rated resistance	Tc = 25°C		5		kΩ
Δ <i>R</i> /R	Deviation of R100	$T_{\rm C} = 100^{\circ}{\rm C}, {\rm R}_{100} = 493\Omega$	-5		5	%
P ₂₅	Power dissipation	Tc = 25°C			20	m/W
B _{25/50}		$R_2 = R_{25} exp [B_{25/50}(1/T2 - 1/(298.15K))]$		3375		K
B _{25/80}	B-value	$R_2 = R_{25} exp [B_{25/80}(1/T2 - 1/(298.15K))]$		3411		K
B _{25/100}		$R_2 = R_{25} exp [B_{25/100}(1/T2 - 1/(298.15K))]$		3433		K

 $^{^{\}star}$ L is the circuit inductance + L_M

ELECTRICAL CHARACTERISTICS

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time		<i>dv/dt</i> = 5000V/μs		760		ns
t f	Fall time				360		ns
Eoff	Turn-off energy loss				135		mJ
t _{d(on)}	Turn-on delay time		<i>di/dt</i> = 7700A/µs		285		ns
tr	Rise time				81		ns
Eon	Turn-on energy loss				45		mJ
Q _{rr}	Diode reverse recovery charge	I _F = 600A V _{CE} = 900V		155		μC	
Irr	Diode reverse recovery current			720		Α	
Erec	Diode reverse recovery energy	di/dt = 7	700A/µs		123		mJ

T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$I_{C} = 600A$ $V_{CE} = 900V$ $V_{GE} = \pm 15V$ $R_{G(OFF)} = 1.0\Omega$ $R_{G(ON)} = 1.0\Omega$ $L_{S} \sim 60nH$	<i>dv/dt</i> = 5000V/μs		860		ns
t _f	Fall time				500		ns
Eoff	Turn-off energy loss				183		mJ
t _{d(on)}	Turn-on delay time		di/dt = 7700A/µs		295		ns
t _r	Rise time				85		ns
Eon	Turn-on energy loss				61		mJ
Qrr	Diode reverse recovery charge	I _F = 600A V _{CE} = 900V		250		μC	
Irr	Diode reverse recovery current		: 900V		810		Α
Erec	Diode reverse recovery energy	di/dt = 7	700A/µs		192		mJ

T_{case} = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	$\begin{array}{c} I_{C} = 600A \\ V_{CE} = 900V \\ V_{GE} = \pm 15V \\ R_{G(OFF)} = 1.0\Omega \\ R_{G(ON)} = 1.0\Omega \\ L_{S} \sim 60 nH \end{array}$			870		ns
t f	Fall time		<i>dv/dt</i> = 5000V/μs		535		ns
Eoff	Turn-off energy loss				194		mJ
t _{d(on)}	Turn-on delay time		<i>di/dt</i> = 7700A/μs		300		ns
t r	Rise time				86		ns
Eon	Turn-on energy loss				67		mJ
Qrr	Diode reverse recovery charge	I _F = 600A V _{CE} = 900V		270		μC	
Irr	Diode reverse recovery current		= 900V		830		Α
Erec	Diode reverse recovery energy	di/dt = 7	7700A/µs		209		mJ

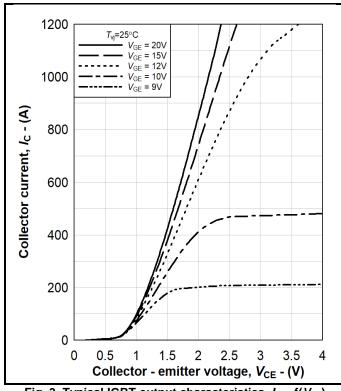


Fig. 3 Typical IGBT output characteristics, $I_C = f(V_{CE})$

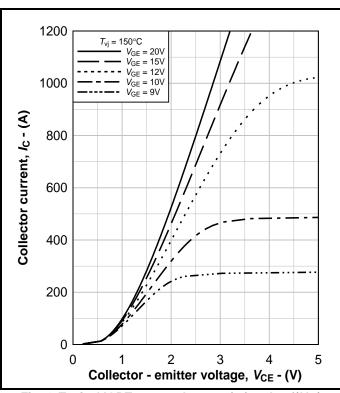


Fig. 4 Typical IGBT output characteristics, $I_C = f(V_{CE})$

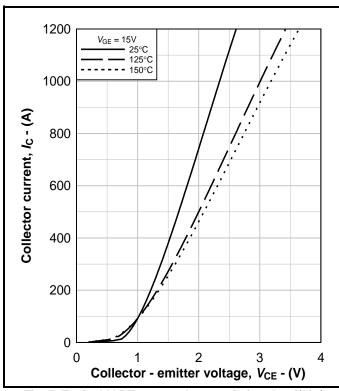


Fig. 5 Typical IGBT output characteristics, $I_C = f(V_{CE})$

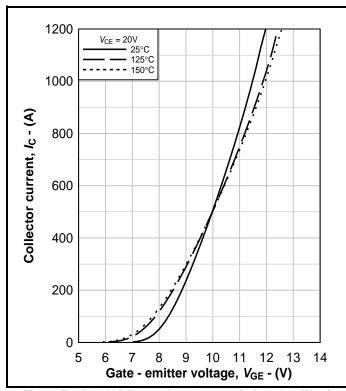
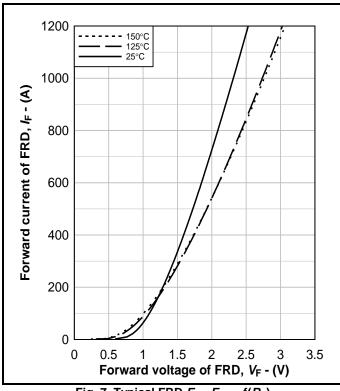


Fig. 6 Typical IGBT transfer characteristics, $I_C = f(V_{GE})$





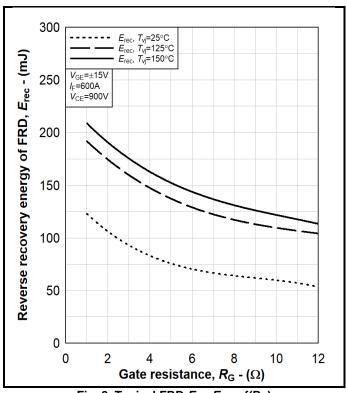


Fig. 8 Typical FRD E_{rec} , $E_{rec} = f(R_G)$

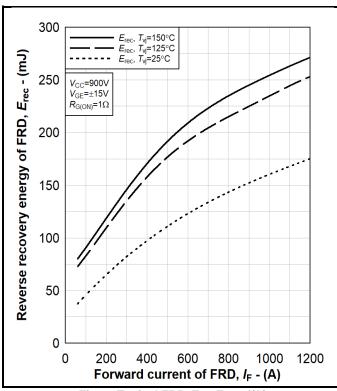


Fig. 9 Typical FRD E_{rec} , $E_{rec} = f(I_F)$

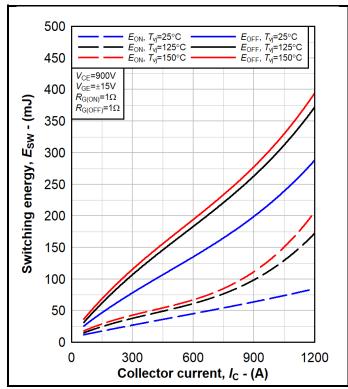


Fig. 10 Typical IGBT switching energy, $E_{ON} = f(I_C), E_{OFF} = f(I_C)$

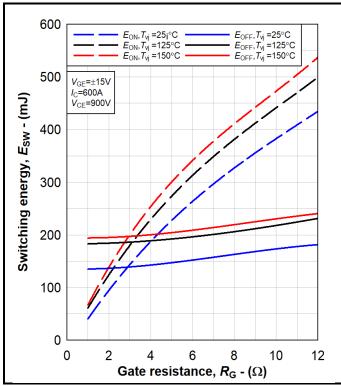


Fig. 11 Typical IGBT switching energy $E_{ON} = f(R_G)$, $E_{OFF} = fR_G$)

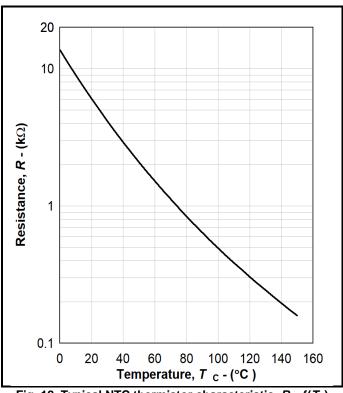


Fig. 12 Typical NTC thermistor characteristic, $R = f(T_C)$

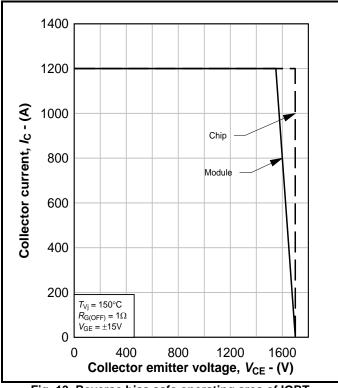


Fig. 13 Reverse bias safe operating area of IGBT, $I_C = f(V_{CE})$

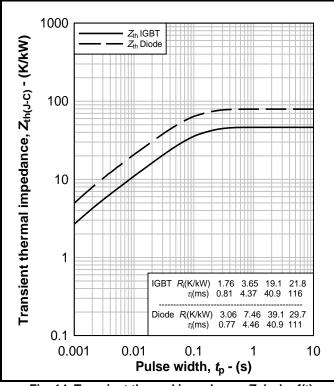


Fig. 14 Transient thermal impedance, $Z_{th(J-C)} = f(t)$

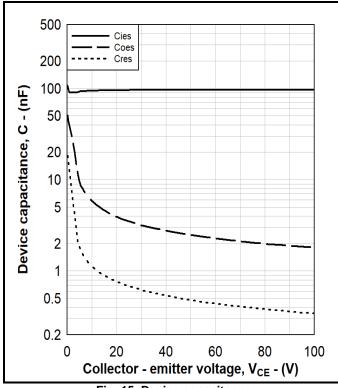


Fig. 15 Device capacitance

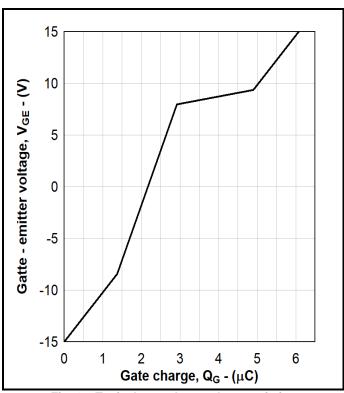


Fig. 16 Typical gate charge characteristics

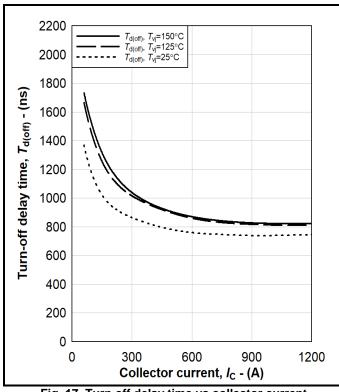


Fig. 17 Turn off delay time vs collector current

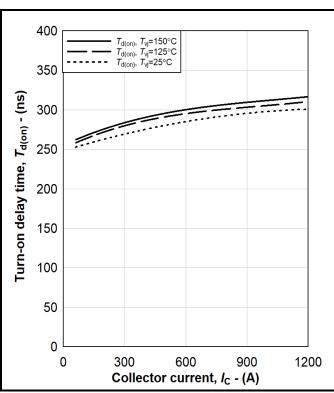
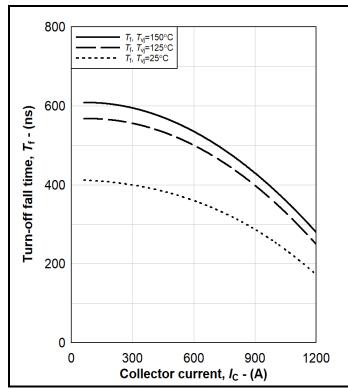


Fig. 18 Turn on delay time vs collector current



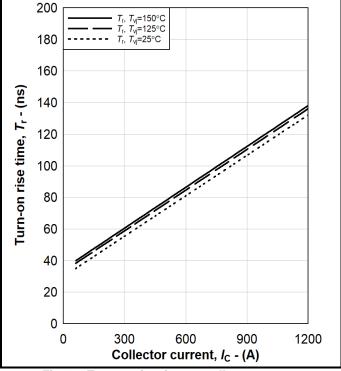


Fig. 19 Turn-off time vs collector current

Fig. 20 Turn-on rise time vs collector current

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

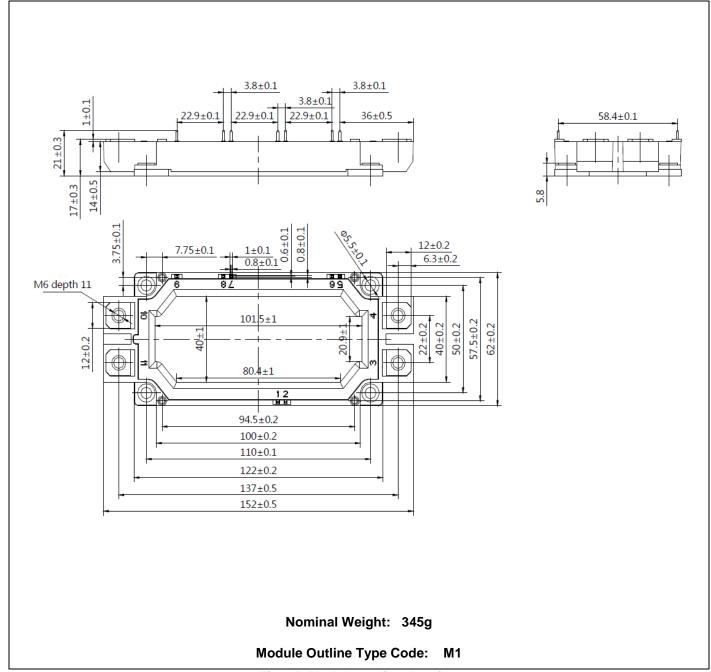


Fig. 15 Module outline drawing

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HEADQUARTERS OPERATIONS

DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln, Lincolnshire, LN6 3LF, United Kingdom

Tel: +44(0)1522 500500 Web: http://www.dynexsemi.com

CUSTOMER SERVICE

DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln, Lincolnshire, LN6 3LF, United Kingdom

Tel: +44(0)1522 502753 / 502901 Email: powersolutions@dynexsemi.com

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